

## **DUAL P-CHANNEL 30V ENHANCEMENT MODE MOSFET**

### **SUMMARY**

 $V_{(BR)DSS} = -30V; R_{DS(ON)} = 0.045\Omega; I_{D} = -5.5A$ 

### DESCRIPTION

This new generation of trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

## **FEATURES**

- Low on-resistance
- Fast switching speed
- Low threshold
- Low gate drive
- Low profile SOIC package

### APPLICATIONS

- Motor Drive
- LCD backlighting

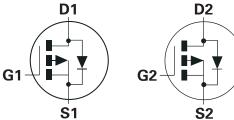
### **ORDERING INFORMATION**

DEVICE	REEL	TAPE WIDTH	QUANTITY PER REEL
ZXMP3A16DN8TA	7"	12mm	500 units
ZXMP3A16DN8TC	13′'	12mm	2500 units

### **DEVICE MARKING**

ZXMP 3A16





PINOUT

S1	0	D1
G1	Dual	D1
S2 🗔	Device	D2
G2 🗔		D2

Top view



## ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	V <sub>DSS</sub>	-30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
$ \begin{array}{c} \mbox{Continuous Drain Current} @V_{GS} = 10V; \ T_A = 25^\circ C \ {}^{(b)(d)} \\ @V_{GS} = 10V; \ T_A = 70^\circ C \ {}^{(b)(d)} \\ @V_{GS} = 10V; \ T_A = 25^\circ C \ {}^{(a)(d)} \end{array} $	I <sub>D</sub>	-5.5 -4.4 -4.2	A A A
Pulsed Drain Current <sup>(c)</sup>	I <sub>DM</sub>	-20	А
Continuous Source Current (Body Diode) <sup>(b)</sup>	I <sub>S</sub>	-3.2	A
Pulsed Source Current (Body Diode) <sup>(c)</sup>	I <sub>SM</sub>	-20	A
Power Dissipation at T <sub>A</sub> =25°C <sup>(a)(d)</sup> Linear Derating Factor	P <sub>D</sub>	1.25 10	W mW/°C
Power Dissipation at T <sub>A</sub> =25°C <sup>(a)(e)</sup> Linear Derating Factor	P <sub>D</sub>	1.8 14	W mW/°C
Power Dissipation at T <sub>A</sub> =25°C <sup>(b)(d)</sup> Linear Derating Factor	P <sub>D</sub>	2.1 17	W mW/°C
Operating and Storage Temperature Range	T <sub>j</sub> :T <sub>stg</sub>	-55 to +150	°C

## THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient <sup>(a)(d)</sup>	$R_{\theta JA}$	100	°C/W
Junction to Ambient <sup>(b)(e)</sup>	$R_{\theta JA}$	70	°C/W
Junction to Ambient <sup>(b)(d)</sup>	$R_{\theta JA}$	60	°C/W

Notes

(a) For a dual device surface mounted on 25mm x 25mm FR4 PCB with coverage of single sided 1oz copper in still air conditions.

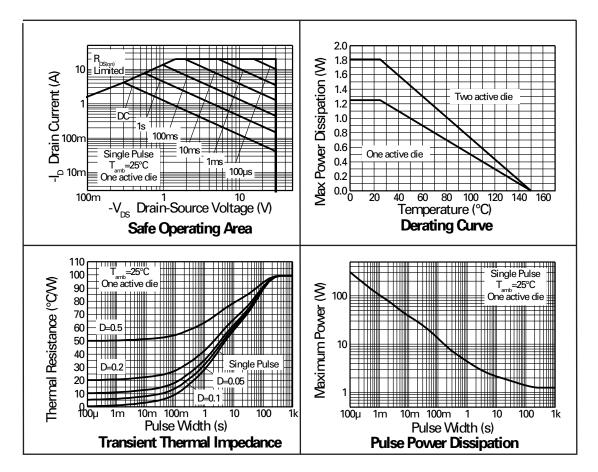
(b) For a dual device surface mounted on FR4 PCB measured at t  ${\leq}10$  sec.

(c) Repetitive rating 25mm x 25mm FR4 PCB, D=0.05 pulse width=10µs - pulse width limited by maximum junction temperature.

(d) For a dual device with one active die.

(e) For dual device with 2 active die running at equal power.





## **CHARACTERISTICS**



PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS	
STATIC	1				1	1	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	-30			V	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			-1.0	μA	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V	
Gate-Body Leakage	I <sub>GSS</sub>			100	nA	$V_{GS}=\pm 20V, V_{DS}=0V$	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	-1.0			V	I_=-250μA, V <sub>DS</sub> = V <sub>GS</sub>	
Static Drain-Source On-State Resistance (1) R				0.045 0.070	Ω Ω	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.4A	
Forward Transconductance <sup>(1)(3)</sup>	g <sub>fs</sub>		9.2		S	V <sub>DS</sub> =-15V,I <sub>D</sub> =-4.2A	
DYNAMIC <sup>(3)</sup>							
Input Capacitance	C <sub>iss</sub>		1022		pF	V <sub>DS</sub> =-15 V, V <sub>GS</sub> =0V, f=1MHz	
Output Capacitance	C <sub>oss</sub>		267		pF		
Reverse Transfer Capacitance	C <sub>rss</sub>		229		pF		
SWITCHING <sup>(2) (3)</sup>							
Turn-On Delay Time	t <sub>d(on)</sub>		3.8		ns		
Rise Time	t <sub>r</sub>		6.5		ns	V <sub>DD</sub> =-15V, I <sub>D</sub> =-1A R <sub>G</sub> =6.0Ω, V <sub>GS</sub> =-10V	
Turn-Off Delay Time	t <sub>d(off)</sub>		37.1		ns		
Fall Time	t <sub>f</sub>		21.4		ns		
Gate Charge	Qg		17.2		nC	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-5V, I <sub>D</sub> =-4.2A	
Total Gate Charge	Qg		29.6		nC		
Gate-Source Charge	Q <sub>gs</sub>		2.8		nC	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-10V, I <sub>D</sub> =-4.2A	
Gate-Drain Charge	Q <sub>gd</sub>		8.6		nC		
SOURCE-DRAIN DIODE							
Diode Forward Voltage <sup>(1)</sup>	V <sub>SD</sub>		-0.85	-0.95	V	T <sub>J</sub> =25°C, I <sub>S</sub> =-3.6A, V <sub>GS</sub> =0V	
Reverse Recovery Time <sup>(3)</sup>	t <sub>rr</sub>		21.7		ns	$T_{J}=25^{\circ}C, I_{F}=-2A,$	
Reverse Recovery Charge <sup>(3)</sup>	Q <sub>rr</sub>		16.1		nC	di/dt= 100Å/µs	

## **ELECTRICAL CHARACTERISTICS** (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

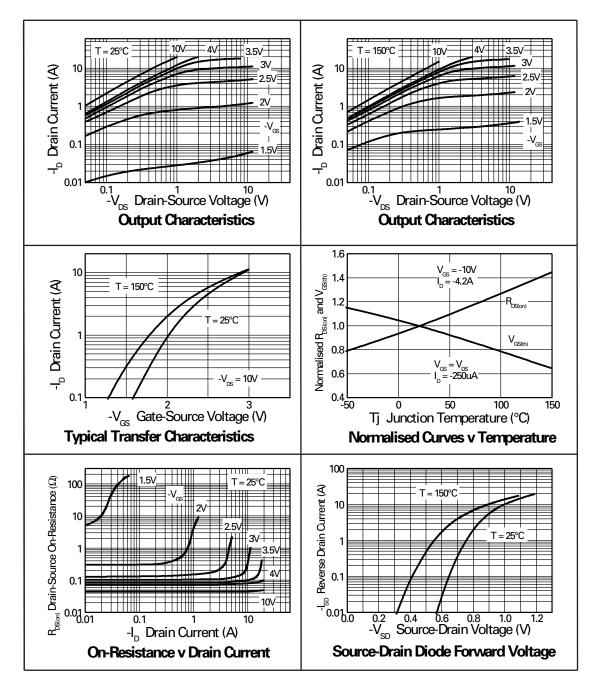
NOTES

(1) Measured under pulsed conditions. Width  ${\leq}300\mu s.$  Duty cycle  ${\leq}\,2\%$  .

(2) Switching characteristics are independent of operating junction temperature.

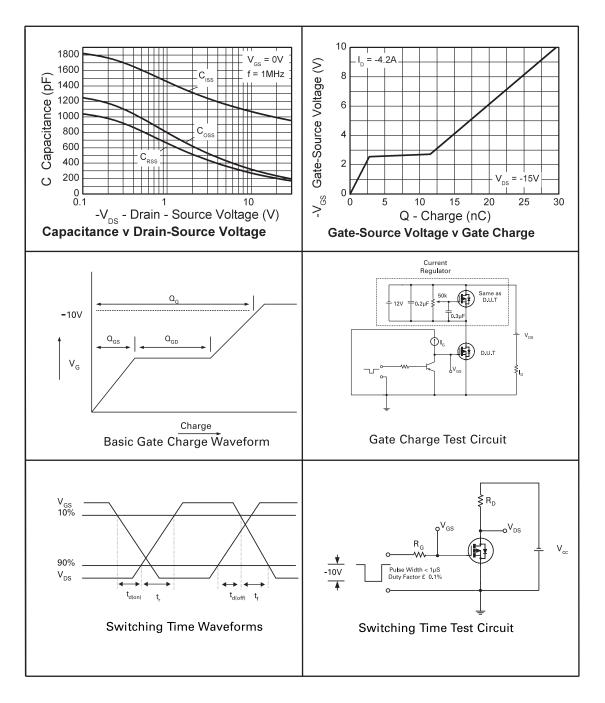
(3) For design aid only, not subject to production testing.





## **TYPICAL CHARACTERISTICS**







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Datasheet status key:

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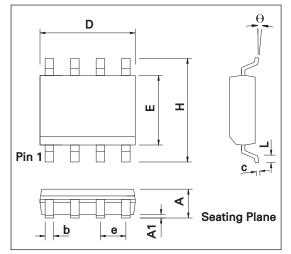
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## PACKAGE OUTLINE



CONTROLLING DIMENSIONS ARE IN INCHES APPROX IN MILLIMETRES

## PACKAGE DIMENSIONS

	Millin	neters	Inc	hes		Millimeters		Inches	
DIM	Min	Мах	Min	Мах	DIM	Min	Мах	Min	Мах
А	1.35	1.75	0.053	0.069	е	1.27	BSC	0.050	BSC
A1	0.10	0.25	0.004	0.010	b	0.33	0.51	0.013	0.020
D	4.80	5.00	0.189	0.197	с	0.19	0.25	0.008	0.010
н	5.80	6.20	0.228	0.244	θ	0°	8°	0°	8°
Е	3.80	4.00	0.150	0.157	h	0.25	0.50	0.010	0.020
L	0.40	1.27	0.016	0.050	-	-	-	-	-

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